

Notice of References Cited	Application/Control No. 09/871,467		Applicant(s)/Patent Under Reexamination CHEN ET AL.	
	Examiner Katarzyna Wyrozebski Lee		Art Unit 1714	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,646,207	07-1997	Schell	524/47
	B	US-6,099,773	08-2000	Reck et al	264/109
	C	US-5,763,524	06-1998	Arkens et al.	524/549
	D	US-2002/0091185	07-2002	Taylor et al.	524/249
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
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FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

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